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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

: Kenji KANEKO et al.

Group Art Unit: 3662

Appl. No.

ants

: 10/808,577

Examiner: Not Yet Assigned

Filed

: March 25, 2004

For

: SURVEYING INSTRUMENT HAVING AN OPTICAL DISTANCE METER AND AN AUTOFOCUS SYSTEM, AND A SURVEYING INSTRUMENT HAVING A DETACHABLE AUTOFOCUS SYSTEM

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the duty of disclosure under 37 C.F.R. §1.56 and §§1.97-1.98, Applicants hereby call to the Examiner's attention the following documents which were cited during the prosecution of parent application U.S. Patent Application No. 09/938,663, which issued as U.S. Patent No. 6,734,410 to KANEKO et al. on May 11, 2004:

- U.S. Patent No. 5,872,661 to SUZUKI et al., which issued on February 16, 1999;
- U.S. Patent No. 5,877,892 to NAKAMURA et al., which issued on March 2,

1999;

- U.S. Patent No. 5,923,468 to TSUDA et al., which issued on July 13, 1999;
- U.S. Patent No. 5,936,736 to SUZUKI et al., which issued on August 10, 1999;
- U.S. Patent No. 6,072,642 to SHIRAI, which issued on June 6, 2000;

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U.S. Patent No. 6,266,911 to SUZUKI, which issued on July 31, 2001; and U.S. Patent No. 6,269,580 to SUZUKI, which issued on August 7, 2001.

Copies of the above-noted documents are not being provided further to 37 C.F.R. §1.98 (d)(i) as they have already been submitted during the prosecution of the parent application.

Applicants respectfully request that the Examiner consider the above material and cite the same. All of the above-noted documents are listed on the attached PTO-1449 Form. The Examiner is requested to initial the appropriate spaces on the attached Form and to return a copy of the completed Form to the Applicants with the next official communication in the present application.

Applicants also bring to the Examiner's attention the following co-pending, commonly assigned patent application:

U.S. Patent Application No. 10/808,351 to KANEKO et al., entitled "Surveying Instrument Having an Optical Distance Meter and an Autofocus System, and a Surveying Instrument Having a Detachable Autofocus System," which was filed on March 25, 2004.

In accordance with 37 C.F.R. §1.98 (a)(2)(iii), a copy of the above-noted application is attached. However, the Examiner is also requested to review the file wrapper of this U.S. patent application at the U.S. Patent and Trademark Office and the references of record, if any, cited therein.

P25048.A01.doc

Should the Examiner have any questions, the Examiner is invited to contact the undersigned at the below-listed telephone number.

Respectfully Submitted, Kenji KANEKO et al.

200 Reg. No. 48, 214

Bruce H. Bernstein Reg. No. 29,027

June 23, 2004 GREENBLUM & BERNSTEIN, P.L.C. 1950 Roland Clarke Place Reston, VA 20191 (703) 716-1191

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